

<b>Notice of References Cited</b>	Application/Control No. 10/596,880		Applicant(s)/Patent Under Reexamination KANEKIYO ET AL.	
	Examiner John P. Sheehan		Art Unit 1793	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0194856 A1	10-2004	Miyoshi et al.	148/105
*	B	US-2004/0099346 A1	05-2004	Nishiuchi et al.	148/302
*	C	US-2004/0051614 A1	03-2004	Kaneakiyo et al.	335/302
*	D	US-2004/0020569 A1	02-2004	Kaneakiyo et al.	148/302
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	U				
	V				
	W				
	X				

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.